NO. :



APPROVAL SHEET

MULTILAYER CERAMIC CAPACITOR Commercial Grade

(General Type)

Approved by customer : (signing or stamping here)

SAMWHA CAPACITOR CO., LTD. Writtern by Checked by Approved by

2020. 03. 04.

SAMWHA CAPACITOR CO., LTD.

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	< SPE	EC S	SUMMARY >
SAMWHA Part no.		CS2	012X7R222K500NRA
Туре			General
Item	Specification	Unit	Test methods and Conditions(Capacitance,IR)
Capacitance	2.2	nF	
Capacitance Tolerance	± 10	%	Testing Frequency: 1 ±0.1kHz Testing Voltage: 1 ±0.2Vrms
Dissipation Factor	Max. 2.5	%	
Insulation Resistance	More than 10,000	MQ	Applied the rated voltage for 2 minutes of charging.
	2.00 ±0.20	L (mm)	
Chip Size	1.25 ±0.15	W (mm)	*Chip size page 2/9
	0.60 ±0.10	T (mm)	*Characteristics & Test Method page 3/9~6/9

		S	FANDAF	RD			NO	SW	/ - M - 0
Enactment : March 27,19	996	MULTILAYER	CERAMIC	CAF	PACITO	R		_	1 / 0
	/	Com	mercial G	Grade			Pag	e	1 / 9
	ions refer to omputer equ strial equip se contact	uipment, comm	nunication high relia	equipr <u>bility (</u>	nent. e quipme	nt / LE			
2. General Code (1) Type Desig	nation								
	<u>CS</u> (1) 2	012 (2) X7R (3)	<u>222</u> (4)	<u>K</u> (5)	<u>500</u> (6)	<u>N</u> (7)	<u>R</u> (8)	<u>A</u> (9)	
1) Multilayer	Ceramic C	apacitor (Com	mercial Gr	ade)					
2) Size Code 3) Temperatu	This is	expressed in s st two digits a ient Code				two di	gits are	width.	
Classif	fication	Code	Temr	peratu	re Range	e	Capacita	nce Tol	erance
Clas		COG	-	55 to +		-		0 ppm/°C	
		X5R		55 to				±15%	
Clas	s II								
		X7R	-5	5 to +	-125℃			±15%	
		Y5V		5 to + 30 to				±15% %~-82°	%
The nomi The first t ex) 104 R (8R: 5) Capacitar Code	ce Code(P nal Capaci wo digits re = 100000 denotes de 2 = 8.2 pF nce Tolerar	Y5V tico farads) : tance Value in epresents signifi pF tocimal nce Code	pF is exp	30 to presse	+85℃ d by thi		+22' it numbe denotes t	% ~ −82° ers. he numk	per of zero
The nomi The first t ex) 104 R (8R) 5) Capacitar	ce Code(P nal Capaci wo digits re = 100000 denotes de 2 = 8.2 pF nce Tolerar	Y5V tico farads) : tance Value in epresents signifi pF ecimal	pF is exp	30 to presse	+85℃ d by thr the last		+22' it numbe denotes t ± 20	% ~ −82° ers. he numk	per of zero

D

F

G

J

Κ

± 0.5 pF

± 1.0 %

 \pm 2.0 %

± 5 %

± 10 %

Ζ

Н

Ι

U

V

+ 80, -20%

+ 0.25/-0 pF

+ 0/-0.25 pF

+ 5/-0 %

+ 0/-5 %

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6) Voltage Code

v	Unage	OUUU													
	code	6R3	100	160	250	350	500	101	201	251	501	631	102	202	302
	Val	DC	DC	DC	DC	DC	DC	DC	DC	DC	DC	DC	DC	DC	DC
	Vol.	6.3V	10V	16V	25V	35V	50V	100V	200V	250V	500V	630V	1KV	2KV	3KV

7) Termination Code

ex) N : Ni-Sn (Nickel-Tin Plate)

A : Ag/Ni-Sn (Ag Epoxy/Nickel-Tin Plate) -> Soft Termination Type

- 8) Packing Code
 - ex) R : 7" Reel Type
 - L: 13" Reel Type
 - B : Bulk Type
- 9) Thickness option

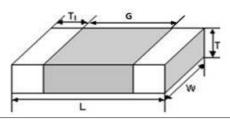
Thickne	ess(mm)	Code	Thickne	ss(mm)	Code
t	Tol(±)	0000	t	Tol(±)	0000
0.30	0.03	Blank	1.30	0.20	E
0.50	0.05	Blank	1.35	0.20	Н
0.60	0.10	A	1.60	0.20	l
0.80	0.10	В	1.80	0.20	J
0.85	0.15	В	2.00	0.25	К
1.00	0.15	E	2.50	0.25	L
1.10	0.15	E	2.80	0.30	М
1.15	0.15	E	3.20	0.30	N
1.25	0.15	E	5.00	0.40	0

3. Temperature Characteristics

See Page 6/9 (No.14)

4. Constructions and Dimensions

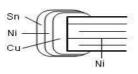
(I) Dimensions



<u>(Unit:mm)</u>

	Dimension								
Code	Len	igth	Wi	dth	T1(min)	O(min)			
	L	Tol(±)	W	Tol(±)	- T1(min)	G(min)			
0603	0.60	0.03	0.30	0.03	0.05	0.15			
1005	1.00	0.05	0.50	0.05	0.05	0.30			
1608	1.60	0.15	0.80	0.10	0.10	0.50			
2012	2.00	0.20	1.25	0.15	0.10	0.65			
3216	3.20	0.30	1.60	0.20	0.15	1.00			
3225	3.20	0.40	2.50	0.25	0.15	1.05			
4520	4.50	0.40	2.00	0.25	0.20	1.50			
4532	4.50	0.40	3.20	0.30	0.20	1.50			
5750	5.70	0.50	5.00	0.40	0.30	1.85			

(2) Construction of Termination



Spe	ecificatio	ons and	Test Methods (G	ene	ral)					
No.	lte	em		Spe	cificati					Test Methods and Conditions
		;iii	Class I				ss II			
1	Operating Temperature Range	2	C0G :-55 to+125℃		X5	R∶-5	5 to +12 5 to +89 0 to +85	Ĵ℃		
2	Insulation Resistance		More th (W	ian 10 /hichei	Applied the rated voltage for 2 minutes of charging, The charge/discharge current is less than 50mA. COG : The rated voltage ×300% X7R, X5R, Y5V : " ×250%					
3			No defects or abnormalities							 Applied between the terminations for 1 to 5 seconds. The charge/discharge current is less than 50mA.
4	Capacitance	9	within	the s	pecified	tolera	ance			The capacitance/Q/D.F. should be measured at 25℃ at the requency
				Ohan	50V	25V	101/	10V	6.01/	and voltage shown in the table. Cap Testing Testing frequency Voltage
			30pFmin	Char.	min	201	16V	100	6.3V	COG (C<1000pF) 1±0.1₩± 0.5to5 Vrms COG (C>1000 pF) 1±0.1₩± 1±0.2
5	Dissipation	 i Q≥1,000(DF≤0.1%) 30pFmax i Q≥400+20C (DF≤1/(400+20C)) 		X7R X5R	≦2.5%/ ∗≦5%	≦3%/ ∗≦7%	≦3.5%/ ∗≦7%	≦5%/ *≦10%	≦5%/ *≦10%	$ \begin{array}{c c} (C \ge 1000 \text{pF}) & \text{Vrms} \\ \hline X7R, X5R, Y5V \\ (C \le 10 \text{µF}) & 1 \pm 0.1 \text{Wz} & 1 \pm 0.2 \\ \hline Vrms & Vrms & 0.5 \pm 0.1 \end{array} $
				Y5V	≦5%/ ∗≦9%	≦7%/ *≦9%	≦9%/ *≦12.5%	≦12.5%/ *≦15%	≤15%	$\begin{array}{c c} 120\pm24\text{Hz} & 0.5\pm0.1 \\ \hline \text{(C>10}\mu\text{F)} & 120\pm24\text{Hz} & \text{Vrms} \end{array}$ Initial measurement Perform the initial measurement according to Note1 for Class II Measurement after test Take it out and set it for
				Termination should be covered with more than 75% of new solder						24±2 hours (Class I) or 24±2 hours (Class II) then measure
6	Solderability Termination	of	-Termination should b 75% of new solder							*Pb-Free type Solder : 96.5Sn-3Ag-0.5Cu Solder temperature : 245±5°C Immersion time : 3±0.1sec *Pre-Heating : at 80~120°C for 10~30sec
		Appearance	No defects v	vhich	may af	fect p	erforma	nce		Preheat the capacitor at 120 to
		Capacitance change	within ±2.5% or ±0.25pF (whichever is larger)	X7R Y5V	, X5R: :	$\leq \pm 7$ $\leq \pm 20$				150°C for 1 minute. (Preheating for 3225,4520,4532 Step1:100°C to 120°C, 1min
			30pFmin : Q≥1,000 (DF≤0.1%)	Char.	50V min	25V	16V	10V	6.3V	Step2:170°C to 200°C, 1min) Immerse the capacitor in a eutectic solder solution
7	Resistance to Soldering	Dissipation Factor (or Q)	30pFmax	X7R X5R	≦2.5%/ *≦5%	≦3%/ *≦7%	≦3.5%/ ∗≦7%	≦5%/ *≦10%	≦5%/ ∗≦10%	·Soldering Temp:260 ±5℃ ·Immersion Time:10 ±0.5 sec
	Heat		: Q≥400+20C (DF≦1/(400+20C))	Y5V	≦5%/ *≦9%	≦7%/ *≦9%	≦9%/ *≦12.5%	≦12.5%/ *≦15%	≦15%	 Initial measurement Perform the initial measurement according to Note1 for Class II
		I.R.		lore than 10,000MΩ or 500Ω.F (whichever is smaller)					Measurement after test Take it out and set it for 24±2 hours (Class I) or 24±2 hours (Class II) then measure	

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				S	pecifica	ation									
No.	l It	em	Class I			Cla	ss II			Tes	t Method	ds an	d Condi	tions	
		Appearance	No defects which m	ay af	fect pe	erforma	nce				rm the fiv				
		Capacitance Change	Within ±2.5% or ±0.25pF (whichever is larger)	X7R, Y5V		Within ± Vithin ±2				follow Step	ving table.	2	3	4	
				Char	50V	25V	16V	10V	6.3V	Min. Max. Temp operating Room operating (°C) temp. Temp temp. +0 -3 +3 -0					
8	Temperature Cycle	Dissipation Factor	30pFmin : Q≥1,000 (DF≤0.1%)	X7R X5R	min ≦5%/ ∗≦7.5%	≦5%/ *≦10%	≦5%/ *≦10%	≦7.5%/ *≦12.5	≦7.5%/ *≦12.5%	Time (min)	+0, -3 30±3	2 to3	+3, -0 30±3	2 to3	
	Gycie	(or Q)	30pFmax : Q≥400+20C (DF≤1/(400+20C))	Y5V	≦7.5%/ ∗≦12.5%	≦10%/ *≦12.5%	≦12.5%/ *≦15%	≦15%/ ∗≦20%	≦20%	 Initial measurement Perform the initial mea according to Note1 for 					
		I.R	More)MΩ or 5 s smalle				Perfo	urement a orm the f ording to	inal m	easurem	ent	
		Appearance	No defects which m	-						·Temp	erature :	40+2°	2		
		Capacitance Change	Within ±7.5% or ±0.75pF (whichever is larger)	Y5V	: (Y5V/1.0	: Within + Within µF,2.2µF ±30% (30%, -4 ,4.7µF/1			·Humio ·Hour ·Applie	dity : 90~ : 500+24/ ed Voltage	95%RH -0 hrs : Rat	H ed Voltag		
9	Humidity		30pFmin : Q≧200 (DF≦0.5%)	Char	501/	25V	16V	10V	6.3V	d i i i i i i i i i i i i i i i i i i i	charge/dis than 50m/		current is		
9	Load	Dissipation Factor(or Q)	30pFmax : Q≧100+10/3C	X7R X5R		≦5%/ *≦10%	≦5%/ *≦10%	≦7.5%/ *≦12.5	≦7.5%/ *≦12.5%	Perfo	measure orm the i ording to	nitial			
			DF≤1/(100+10/3C)	Y5V	*≦12.5%		≦12.5%/ *≦15%	≦15%/ *≦20%	≦20%		urement a orm the f			ent	
		I.R	M			lΩ or 259 s smalle					ording to				
		Appearance	No defects which m	ay af	fect pe	erforma	nce			•Testin	g time :	1000+4	18/-0 hrs		
		Capacitance Change	Within ±3% or ±0.3pF (whichever is larger)		Within	Vithin ±1 ±30% (c +30%, − (cap	ap<1.0	uF)		Rated •Temp	ed voltage d voltage erature : G, X7R -	< DC2		00%	
	High		30pFmin : Q≥350 (DF≤0.3%)	Char	. 50V min	25V	16V	10V	6.3V	X: The	5R, Y5V - charge/dis s than 50	→ 85± charge	3°C		
10	Temperature Load	Dissipation Factor	$\begin{array}{l} 10_{\text{p}}F \leq Cp \leq 30_{\text{p}}F \\ \vdots \ Q \geq 275 + 5/2C \\ (DF \leq 1/(275 + 5/2C)) \end{array}$	X7R X5R		≦5%/ *≦10%	≦5%/ *≦10%	≦7.5%/ *≦12.5	≦7.5%/ *≦12.5%	·Initial	measure orm the i	ment	measure	ment	
		(or Q)	10pFmax : Q≥200+10C (DF≤1/(200+10C))	Y5V	≤7.5%/ *≤12.5%		≦12.5%/ *≦15%	≦15%/ *≦20%	≦20%	acco •Measi	urement a promother for	Note1 fter te:	for Clas	ss II	
		I.R						More than 1,000MΩ or 50Ω.F (whichever & smaller)							

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				Sp	pecifica	tion				
No.	lt	em	Class I			Cla	iss II			Test Methods and Conditions
			20mm	᠇	<u> </u>					
11	Bending strength	Capacitance Change	No cracking or ma Within ±5% or ±0.5pF (whichever is larger)	X7R	45n	imm m s shall Within ±				 Substrate material Glass EPOXY Board. Thickness 1.6mm 0.8mm (0603/1005size) *. Test condition Bending limit : 1mm Pressurizing speed : 1mm/sec Holding time : 5±1sec
		Appearance	No defects or abnorr	naliti	es					
		Capacitance	Whin the specified to	leran	ce					*After soldering and then let
12	Vibration Resistance	Q/DF	30pFmin : Q≥1,000 (DF≤0.1%) 30pFmax : Q≥400+20C	Char. X7R X5R	50V min ≤2.5%/ *≤5%	25V ≤3%/ ∗≤7%	16V ≤3.5%/ ∗≤7%	10V ≤5%/ ∗≦10%	6.3V ≤5%/ ∗≤10%	sit for 24±2hr(temperature compensating type), 24±2hr(high dielectric constant type) at room temperature. The capacitor should be subjected to a simple harmonic motion having a total amplitude of 1.5mm, the frequency being varied uniformly between the approximate limits of 10 and 55Hz, shall be traversed(from 10Hz to 55Hz then 10Hz again) in approximately 1 minute.
			(DF≦1/ (400+20C))	Y5V	≦5%/ *≦9%	≦7%/ *≦9%	≦9%/ *≦12.5%	≦12.5%/ *≦15%	≦15%	This motion shall be applied for a period of 2 hours in each 3mutually perpendicular directions(total is 6hours).
		Appearance	No defects which ma	i iy aff	fect pe	rformai	псе			
		Capacitance Change	within ±5% or ±0.5pF (Whichever is larger)		, X5R: : Within			,		·Temperature : 40±2℃ ·Humidity : 90~95%RH
			30pF min : Q≧350 (DF≦0.3%)	Char	50V min	25V	16V	10V	6.3V	Hour : 500+24/-0 hrs
13	Humidity Steady State	Dissipation (or Q)	10pF≤Cp≤30pF : Q≥275+5/2C (DF≤1/(275+5/2C))	X7R X5R	≦5%/ *≦7.5%	≦5%/ *≦10%	≦5%/ *≦10%	≦7.5%/ *≦12.5	≦7.5%/ *≦12.5%	Initial measurement Perform the initial measurement according to Note1 for Class II
			10pFmax : Q≧200+10C (DF≦1/(200+10C))	Y5V	≦7.5%/ *≦12.5%	≦10%/ *≦12.5%	≤12.5%/ *≤15%	≦15%/ *≦20%	≦20%	•Measurement after test Perform the final measurement
		I.R.			n 1,000 never is					according to Note2

				Sp	ecificat	ion				.			
No.	Iter	n	Cla	iss I		CI	ass II			Test N	lethods and Conditions		
14	Capacitance Temperature Characteristics	Capacitance Change			Char.	Temp Range	Reference Temp.	Cap Change	(1)	Temperature Compensating Type The temperature coefficient is determined using the capacitar			
					X7R	-55 to +125℃		Within ±15%		measured in step 3 as a reference When cycling the temperature sequentially from step 1 through 5,(COG: +25 to 125°C) the capacitance shall be with in the			
					X5R	-55 to +85℃	25℃	Within ±15%					
					Y5V	-30 to +85℃		Within +22% -82%		specifie temperat	d tolerance for the ure coefficient. acitance drift is calculated		
										by dividi the max	ng the difference between imum measured values i 1, 3 and 5 by the cap.		
										Step	Temperature(℃)		
										1	25±2		
			Tem	o Temperature						2	-55±3		
		Tomporatura	Char. Rang							3	25±2		
		Temperature Coefficient								4	125±3(for C0G)		
			C0G -55 t +125	+30 ppm/°C						5	25±2		
										The rang change over value over range sho	ectric Constant Type es of capacitance compared with the 25°C r the temperature own in the table shall be ecified range.		

*Note2. Measurement after test

1.Class I Let sit for 24±2 hours at room temperature,then measurement

2.Class II

Perform a heat treatment at 150+0,-10°C for one hour and then let sit for 24±2 hours at room temperature, then measure.

	 2 5 Polyb 3 10 Inne 			NY.					
(2) Reel Pac		n noves t							
	① 8~10 F	Poole por	Innor boy						
	2 6 Inner			,					
2) Deel Dim		Doxes he		κ.					
(3) Reel Dim	lensions								(
		MARK	SIZE	Α	В	с	D	E	(Unit : r W
(স্কিঁম)			0603~3225		Φ50Min	Φ13±0.5	Φ21±0.8		
\ SI /j		7 " REEL	4520~4532			Φ13±0.2	Φ57-0+1		
	_ ԼաԼ	13 " REEL	1005~3225	5 Φ330±2	Φ70Min	Φ13±0.5	Φ21±0.8	3 2±0.5	5 10±1
	r i								
(4)Number c	of Package								
				7"			13"		
TYPE		IA CODE		Qt/REEL			Qt/REEL		
CS060 CS100		CC0201 CC0402		15,000			50,000		
CS160		CC0603		4,000			15,000		
CS201		CC0805		3,000 ~ 4,00			000 ~ 15,		
CS321 CS322		CC1206 CC1210		2,000 ~ 4,00 1,000 ~ 3,00			$\frac{000 \sim 10,0}{000 \sim 10,0}$		
CS452		CC1210 CC1808		$\frac{1,000}{1,500} \sim 3,00$		4,	-	000	
CS453	32	CC1812		500 ~ 1,000		1	,500 ~ 5,0	00	
(5) Tape D	imensions					0.3m	•× (0.4max +	
	Imensions				A			• • • • • • • • • • • • • • • • • • •	
					E			A THE AND AND A THE AND A THE ATHENA AND AND A THE ATHENA AND A THE ATHENA	J
C D CHI	P INSERT	A 0.67±0.05	B 0.37±0.05 8	C D .0±0.3 3.5±C	РАРЕ Е .05 1.75±0.1	F 2.0±0.05	G 2.0±0.1	н 4.0±0.1	1.5±0.1
C C C C C C C C C C C C C C C C C C C	P INSERT EIA CODE CC0201 CC0402	A 0.67±0.05 1.15±0.1	B 0.37±0.05 0.65±0.1 8	C D .0±0.3 3.5±0 .0±0.3 3.5±0	PAPE .05 1.75±0.1 .05 1.75±0.1	F 2.0±0.05 2.0±0.05	G 2.0±0.1	H 4.0±0.1	1.5±0.1 1.5±0.1
C D CHI	P INSERT	A 0.67±0.05	B 0.37±0.05 0.65±0.1 1.10±0.2 8	C D .0±0.3 3.5±C .0±0.3 3.5±C .0±0.3 3.5±C	E .05 1.75±0.1 .05 1.75±0.1 .05 1.75±0.1	F 2.0±0.05 2.0±0.05 4.0±0.1	G 2.0±0.1 2.0±0.1 2.0±0.1	H 4.0±0.1 4.0±0.1	1.5±0.1
C C C C C C C C C C C C C C C C C C C	P INSERT EIA CODE CC0201 CC0402	A 0.67±0.05 1.15±0.1	B 0.37±0.05 0.65±0.1 1.10±0.2 8	C D .0±0.3 3.5±0 .0±0.3 3.5±0	E .05 1.75±0.1 .05 1.75±0.1 .05 1.75±0.1	F 2.0±0.05 2.0±0.05 4.0±0.1	G 2.0±0.1 2.0±0.1 2.0±0.1	H 4.0±0.1	1.5±0.1 1.5±0.1
E C C D C C	P INSERT EIA CODE CC0201 CC0402 CC0603	A 0.67±0.05 1.15±0.1 1.9±0.2	B 0.65±0.1 1.65±0.2 8	C D .0±0.3 3.5±C .0±0.3 3.5±C .0±0.3 3.5±C	E .05 1.75±0.1 .05 1.75±0.1 .05 1.75±0.1 .05 1.75±0.1 .05 1.75±0.1	F 2.0±0.05 2.0±0.1 4.0±0.1	G 2.0±0.1 2.0±0.1 2.0±0.1 2.0±0.1	H 4.0±0.1 4.0±0.1 4.0±0.1	1.5±0.1 1.5±0.1 1.5±0.1
E ↓ C D C D C C	J P INSERT EIA CODE CC0201 CC0402 CC0603 CC0805	A 0.67±0.05 1.15±0.1 1.9±0.2 2.4±0.2	B 0.37±0.05 8 0.65±0.1 1.10±0.2 8 1.65±0.2 8 2.00±0.2 8	C D .0±0.3 3.5±0 .0±0.3 3.5±0 .0±0.3 3.5±0 .0±0.3 3.5±0 .0±0.3 3.5±0	E .05 1.75±0.1 .05 1.75±0.1 .05 1.75±0.1 .05 1.75±0.1 .05 1.75±0.1 .05 1.75±0.1	F 2.0±0.05 2.0±0.05 2.0±0.05 4.0±0.1 4.0±0.1 4.0±0.1 4.0±0.1	G 2.0±0.1 2.0±0.1 2.0±0.1 2.0±0.1 2.0±0.1 2.0±0.1	H 4.0±0.1 4.0±0.1 4.0±0.1	1.5±0.1 1.5±0.1 1.5±0.1 1.5±0.1
TYPE CS0603 CS1005 CS1608 CS2012 CS3216	U INSERT ■ INS	A 0.67±0.05 1.15±0.1 1.9±0.2 2.4±0.2 3.6±0.2	B 0.37±0.05 8 0.65±0.1 1.10±0.2 8 2.00±0.2 8 2.80±0.2 8	C D .0±0.3 3.5±0 .0±0.3 3.5±0 .0±0.3 3.5±0 .0±0.3 3.5±0 .0±0.3 3.5±0 .0±0.3 3.5±0 .0±0.3 3.5±0	E .05 1.75±0.1 .05 1.75±0.1 .05 1.75±0.1 .05 1.75±0.1 .05 1.75±0.1 .05 1.75±0.1 .05 1.75±0.1	F 2.0±0.05 2.0±0.05 4.0±0.1 4.0±0.1	G 2.0±0.1 2.0±0.1 2.0±0.1 2.0±0.1 2.0±0.1 2.0±0.1 2.0±0.1	н 4.0±0.1 4.0±0.1 4.0±0.1 4.0±0.1 4.0±0.1	$1.5\pm0.1 \\ 1.5\pm0.1 \\ 1.5\pm0.1 \\ 1.5\pm0.1 \\ 1.5\pm0.1 \\ 1.5\pm0.1$
E Image: C C D C D C D C C C C C S	J P INSERT EIA CODE CC0201 CC0402 CC0603 CC0805 CC1206 CC1210	A 0.67±0.05 1.15±0.1 1.9±0.2 2.4±0.2 3.6±0.2 3.6±0.2	B 0.37±0.05 8 1.10±0.2 8 2.80±0.2 8 2.3±0.2 12	C D .0±0.3 3.5±C	E 05 1.75±0.1 .05 1.75±0.1 .05 1.75±0.1 .05 1.75±0.1 .05 1.75±0.1 .05 1.75±0.1 .05 1.75±0.1 .05 1.75±0.1 .05 1.75±0.1 .05 1.75±0.1	F 2.0 2.0±0.05 2.0±0.05 2.0±0.05 4.0±0.1 4.0±0.1 4.0±0.1 4.0±0.1 4.0±0.1 8.0±0.1 8.0±0.1	G 2.0±0.1 2.0±0.1 2.0±0.1 2.0±0.1 2.0±0.1 2.0±0.1 2.0±0.1 2.0±0.1	H 4.0±0.1 4.0±0.1 4.0±0.1 4.0±0.1 4.0±0.1	$1.5\pm0.1 \\ 1.5\pm0.1 \\ 1.5\pm0.1 \\ 1.5\pm0.1 \\ 1.5\pm0.1 \\ 1.5\pm0.1 \\ 1.5\pm0.1$
TYPE CS1005 CS1005 CS1608 CS2012 CS3216 CS3225 CS4520	U U U U U U U U U U U U U U	A 0.67±0.05 1.15±0.1 1.9±0.2 2.4±0.2 3.6±0.2 3.6±0.2 4.8±0.2	B 0.37±0.05 8 1.10±0.2 8 2.80±0.2 8 2.3±0.2 12	C D .0±0.3 3.5±0 .0±0.3 3.5±0 .0±0.3 3.5±0 .0±0.3 3.5±0 .0±0.3 3.5±0 .0±0.3 3.5±0 .0±0.3 3.5±0 .0±0.3 3.5±0 .0±0.3 3.5±0 .0±0.3 3.5±0	E 05 1.75±0.1 .05 1.75±0.1 .05 1.75±0.1 .05 1.75±0.1 .05 1.75±0.1 .05 1.75±0.1 .05 1.75±0.1 .05 1.75±0.1 .05 1.75±0.1 .05 1.75±0.1	F 2.0 2.0±0.05 2.0±0.05 2.0±0.05 4.0±0.1 4.0±0.1 4.0±0.1 4.0±0.1 4.0±0.1 8.0±0.1 8.0±0.1	G 2.0±0.1 2.0±0.1 2.0±0.1 2.0±0.1 2.0±0.1 2.0±0.1 2.0±0.1 2.0±0.1	H 4.0±0.1 4.0±0.1 4.0±0.1 4.0±0.1 4.0±0.1 4.0±0.1 4.0±0.1 4.0±0.1 4.0±0.1	$1.5\pm0.1 \\ 1.5\pm0.1 \\ 1.5\pm$
TYPE CS1005 CS1005 CS1608 CS2012 CS3216 CS3225 CS4520	U U U U U U U U U U U U U U	A 0.67±0.05 1.15±0.1 1.9±0.2 2.4±0.2 3.6±0.2 3.6±0.2 4.8±0.2	B 0.37±0.05 8 1.10±0.2 8 2.80±0.2 8 2.3±0.2 12	C D .0±0.3 3.5±0 .0±0.3 3.5±0 .0±0.3 3.5±0 .0±0.3 3.5±0 .0±0.3 3.5±0 .0±0.3 3.5±0 .0±0.3 3.5±0 .0±0.3 3.5±0 .0±0.3 3.5±0 .0±0.3 3.5±0 .0±0.3 5.5±0	E 05 1.75±0.1 .05 1.75±0.1 .05 1.75±0.1 .05 1.75±0.1 .05 1.75±0.1 .05 1.75±0.1 .05 1.75±0.1 .05 1.75±0.1 .05 1.75±0.1 .05 1.75±0.1	F 2.0±0.05 2.0±0.05 2.0±0.05 4.0±0.1 4.0±0.1 4.0±0.1 4.0±0.1 8.0±0.1	G 2.0±0.1 2.0±0.1 2.0±0.1 2.0±0.1 2.0±0.1 2.0±0.1 2.0±0.1 2.0±0.1	H 4.0±0.1 4.0±0.1 4.0±0.1 4.0±0.1 4.0±0.1 4.0±0.1 4.0±0.1 4.0±0.1 4.0±0.1	$1.5\pm0.1 \\ 1.5\pm0.1 \\ 1.5\pm$
TYPE CS1005 CS1005 CS1608 CS2012 CS3216 CS3225 CS4520	EIA CODE CC0201 CC0402 CC0603 CC1206 CC1210 CC1808 CC1812	A 0.67±0.05 1.15±0.1 1.9±0.2 2.4±0.2 3.6±0.2 4.8±0.2 4.9±0.2	B 0.37±0.05 8 0.65±0.1 1.10±0.2 8 2.00±0.2 8 2.3±0.2 12 3.6±0.2 12	C D .0±0.3 3.5±0 .0±0.3 3.5±0 .0±0.3 3.5±0 .0±0.3 3.5±0 .0±0.3 3.5±0 .0±0.3 3.5±0 .0±0.3 3.5±0 .0±0.3 3.5±0 .0±0.3 5.5±0 2.0±0.3 5.5±0	E .05 1.75±0.1 .05 1.75±0.1 .05 1.75±0.1 .05 1.75±0.1 .05 1.75±0.1 .05 1.75±0.1 .05 1.75±0.1 .05 1.75±0.1 .05 1.75±0.1 .01 1.75±0.1	F 2.0±0.05 2.0±0.05 2.0±0.05 4.0±0.1 4.0±0.1 4.0±0.1 4.0±0.1 8.0±0.1 8.0±0.1	G 2.0±0.1 2.0±0.1 2.0±0.1 2.0±0.1 2.0±0.1 2.0±0.1 2.0±0.1 2.0±0.1	H 4.0±0.1 4.0±0.1 4.0±0.1 4.0±0.1 4.0±0.1 4.0±0.1 4.0±0.1 4.0±0.1 4.0±0.1	$1.5\pm0.1 \\ 1.5\pm0.1 \\ 1.5\pm$
TYPE CS0603 CS1005 CS1608 CS2012 CS3216 CS3225 CS4520 CS4532	U INSERT PINSERT PINSERT CC0201 CC0402 CC0603 CC0805 CC1206 CC1210 CC1808 CC1812 BLAN K	A 0.67±0.05 1.15±0.1 1.9±0.2 2.4±0.2 3.6±0.2 4.8±0.2 4.9±0.2	B 0.37±0.05 8 0.65±0.1 1.10±0.2 8 2.00±0.2 8 2.3±0.2 3.6±0.2 12 3.6±0.2 12 3.6±0.2 12	C D 0±0.3 3.5±0 .0±0.3 3.5±0 .0±0.3 3.5±0 .0±0.3 3.5±0 .0±0.3 3.5±0 .0±0.3 3.5±0 .0±0.3 3.5±0 .0±0.3 3.5±0 .0±0.3 3.5±0 .0±0.3 3.5±0 .0±0.3 5.5±0 2.0±0.3 5.5±0	E .05 1.75±0.1 .05 1.75±0.1 .05 1.75±0.1 .05 1.75±0.1 .05 1.75±0.1 .05 1.75±0.1 .05 1.75±0.1 .05 1.75±0.1 .01 1.75±0.1 .1 1.75±0.1 .1 1.75±0.1 .1 1.75±0.1 .1 1.75±0.1	F 2.0±0.05 2.0±0.05 2.0±0.05 4.0±0.1 4.0±0.1 4.0±0.1 4.0±0.1 8.0±0.1 8.0±0.1 8.0±0.1 2.00 tr	G 2.0±0.1 2.0±0.1 2.0±0.1 2.0±0.1 2.0±0.1 2.0±0.1 2.0±0.1 2.0±0.1 2.0±0.1 DER	H 4.0±0.1 4.0±0.1 4.0±0.1 4.0±0.1 4.0±0.1 4.0±0.1 4.0±0.1 4.0±0.1 4.0±0.1	$1.5\pm0.1 \\ 1.5\pm0.1 \\ 1.5\pm$
TYPE CS0603 CS1005 CS1608 CS2012 CS3216 CS3225 CS4520 CS4532	J ■ <t< td=""><td>A 0.67±0.05 1.15±0.1 1.9±0.2 2.4±0.2 3.6±0.2 4.8±0.2 4.9±0.2</td><td>B 0.37±0.05 8 0.65±0.1 1.0±0.2 8 2.00±0.2 8 2.80±0.2 8 2.80±0.2 8 2.3±0.2 12 3.6±0.2 12 3.6±0.2 12 CHIPS</td><td>C D 0±0.3 3.5±0 .0±0.3 3.5±0 .0±0.3 3.5±0 .0±0.3 3.5±0 .0±0.3 3.5±0 .0±0.3 3.5±0 .0±0.3 3.5±0 .0±0.3 3.5±0 .0±0.3 3.5±0 .0±0.3 3.5±0 .0±0.3 5.5±0 2.0±0.3 5.5±0 </td><td>E .05 1.75±0.1 .05 1.75±0.1 .05 1.75±0.1 .05 1.75±0.1 .05 1.75±0.1 .05 1.75±0.1 .05 1.75±0.1 .05 1.75±0.1 .01 1.75±0.1 .1 1.75±0.1 .1 1.75±0.1 .1 1.75±0.1 .1 1.75±0.1</td><td>F 2.0±0.05 2.0±0.05 2.0±0.05 4.0±0.1 4.0±0.1 4.0±0.1 4.0±0.1 8.0±0.1 8.0±0.1 8.0±0.1 2.00 tr</td><td>G 2.0±0.1 2.0±0.1 2.0±0.1 2.0±0.1 2.0±0.1 2.0±0.1 2.0±0.1 2.0±0.1 2.0±0.1 DER</td><td>H 4.0±0.1 4.0±0.1 4.0±0.1 4.0±0.1 4.0±0.1 4.0±0.1 4.0±0.1 4.0±0.1 4.0±0.1</td><td>$1.5\pm0.1 \\ 1.5\pm0.1 \\ 1.5\pm$</td></t<>	A 0.67±0.05 1.15±0.1 1.9±0.2 2.4±0.2 3.6±0.2 4.8±0.2 4.9±0.2	B 0.37±0.05 8 0.65±0.1 1.0±0.2 8 2.00±0.2 8 2.80±0.2 8 2.80±0.2 8 2.3±0.2 12 3.6±0.2 12 3.6±0.2 12 CHIPS	C D 0±0.3 3.5±0 .0±0.3 3.5±0 .0±0.3 3.5±0 .0±0.3 3.5±0 .0±0.3 3.5±0 .0±0.3 3.5±0 .0±0.3 3.5±0 .0±0.3 3.5±0 .0±0.3 3.5±0 .0±0.3 3.5±0 .0±0.3 5.5±0 2.0±0.3 5.5±0	E .05 1.75±0.1 .05 1.75±0.1 .05 1.75±0.1 .05 1.75±0.1 .05 1.75±0.1 .05 1.75±0.1 .05 1.75±0.1 .05 1.75±0.1 .01 1.75±0.1 .1 1.75±0.1 .1 1.75±0.1 .1 1.75±0.1 .1 1.75±0.1	F 2.0±0.05 2.0±0.05 2.0±0.05 4.0±0.1 4.0±0.1 4.0±0.1 4.0±0.1 8.0±0.1 8.0±0.1 8.0±0.1 2.00 tr	G 2.0±0.1 2.0±0.1 2.0±0.1 2.0±0.1 2.0±0.1 2.0±0.1 2.0±0.1 2.0±0.1 2.0±0.1 DER	H 4.0±0.1 4.0±0.1 4.0±0.1 4.0±0.1 4.0±0.1 4.0±0.1 4.0±0.1 4.0±0.1 4.0±0.1	$1.5\pm0.1 \\ 1.5\pm0.1 \\ 1.5\pm$

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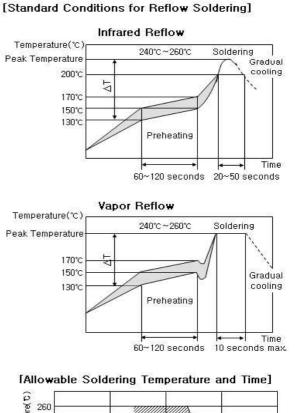
5. Packing

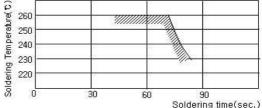
6.Caution

- ► Reflow Soldering
- 1. The sudden temperature change easily causes mechanical damages to ceramic components. Therefore, the preheating procedures should be required for the soldering of ceramic components.
- Please refer to the recommended soldering profiles as shown in figures, and keep the temperature difference(△T) within the range recommended in Table 1.

Table 1

Size code	Temperature Difference
0603, 1005, 1608, 2012, 3216	∆T≤190℃
3225size and over	∆T≤130℃





In case of repeated soldering, the accumulated soldering time must be within the range shown above.

► Storage Condition

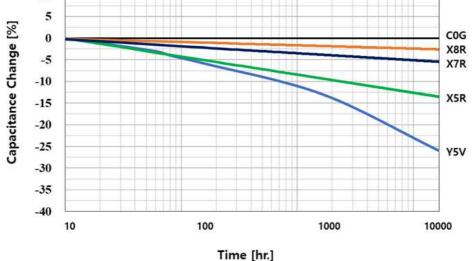
*When Solderability is considered, Capacitor are recommended to be used in 12 months

- (1) Temperature: $25^{\circ}C \pm 10^{\circ}C$
- (2) Relative Humidity: Below 70% RH
- ► The Regulation of Environmental Pollution Materials.

*Never use materials mentioned below in MLCC products regulated this document.

Pb, Cd, Hg, Cr^{+6} , PBB(Polybromide biphenyl), PBDE(Polybrominated diphenyl ethers), asbestos.

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 Note (1) 'Aging'/'De-aging' Behavior of high dielectric MLCCs (Typically represented by X7R, Y5V temperature characteristic of w 	hich main composition is	BaTiO3)
'Aging' / 'De-aging' Behavior of high dielectric MLCCs Please note th Ceramic Capacitors have a "normal" 'aging' behavior / characteristic, value decreases with time from its value when it was first manufactur capacitance value begins to decrease at a logarithmic rate defined by	that is; their capacitance red. From that date, the	
$C_t = C_{24} (1 - k \log 10 t)$		
where :		
Ct = Capacitance Value, t hours after the start of 'aging' C ₂₄ = Capacitance Value, 24 hours after its manufacture k = aging constant (capacitance decrease per decade-hour) t = time, in hours, from the start of 'aging'		
Ceramic's Capacitance Change (%) versus Tin	ne (Hours)	



The capacitance value can be restored (a.k.a. 'de-aged') by exposing the component to elevated temperatures approaching its Curie Temperature (approximately 120°C). This 'deaging' can occur during the component's solder-assembly onto the PCB, during life or temperature cycle testing., or by ' baking ' at 150°C for about 1 hour.